

TEST REPORT

Report Number: R15613923-E11e

Applicant : HID Global Corporation
611 Center Ridge Dr
Austin, TX USA

Model : 40TV2

FCC ID : JQ6-SIGNO40TV2

IC : 2236B-SIGNO40TV2

EUT Description : Signo V2 Reader

Test Standard(s) : FCC 47 CFR PART 1 SUBPART I
FCC 47 CFR PART 2 SUBPART J
OET BULLETIN NO. 65
IEEE C95.3 – 2021
ISED RSS-102 Issue 6

Date Of Issue:

2025-06-10

Prepared by:

UL LLC

12 Laboratory Dr.

Research Triangle Park, NC 27709 U.S.A.

TEL: (919) 549-1400



Revision History

Rev.	Issue Date	Revisions	Revised By
V1	2025-06-10	Initial Issue	Manish Baral

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1. ATTESTATION OF TEST RESULTS

COMPANY NAME: HID Global Corporation
611 Center Ridge Dr
Austin, TX USA

EUT DESCRIPTION: Signo V2 Reader

MODEL: 40TV2

SERIAL NUMBER: 40TTKS-00-000000, 40TTKS-00-000000

SAMPLE RECEIPT DATE: 2025-03-10 and 2025-03-17

DATE TESTED: 2025-03-19 to 2025-04-22

APPLICABLE STANDARDS	
STANDARD	TEST RESULTS
IEEE C95.3-2021	Complies
OET BULLETIN NO. 65	Complies
FCC 47 CFR PART 1 SUBPART I & PART 2 SUBPART J	Complies
ISED RSS-102 Issue 6	Complies

UL LLC tested the above equipment in accordance with the requirements set forth in the above standards. The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report.

The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein. It is the manufacturer's responsibility to assure that additional production units of this model are manufactured with identical electrical and mechanical components. All samples tested were in good operating condition throughout the entire test program. Measurement Uncertainties are published for informational purposes only and were not taken into account unless noted otherwise.

This document may not be altered or revised in any way unless done so by UL LLC and all revisions are duly noted in the revisions section. Any alteration of this document not carried out by UL LLC will constitute fraud and shall nullify the document.

Approved & Released For
UL LLC. By:



Sarah Kuhaneck
Engineer Project Associate
Consumer, Medical and IT Segment.
UL LLC.

Prepared By:



Manish Baral
Engineer
Consumer, Medical and IT Segment.
UL LLC.

2. TEST METHODOLOGY

This report contains data provided by the customer which can impact the validity of results. UL LLC is only responsible for correctly integrating customer-provided data with measurements performed by UL LLC.

All testing / calculations were made in accordance with.

- FCC KDB 447498 D01 General RF Exposure Guidance v06
- FCC KDB 447498 D03 Supplement C Cross-Reference v01
- FCC Parts 1.1310, 2.1091, 2.1093, IEEE Std C95.1-2005, IEEE Std C95.3-2021
- RSS-102 Issue 6
- IC Safety Code 6

3. FACILITIES AND ACCREDITATION

UL LLC is accredited by A2LA, certification # 0751.06, for all testing performed within the scope of this report. Testing was performed at the locations noted below.

	Address	ISED CABID	ISED Company Number	FCC Registration
<input type="checkbox"/>	Building: 12 Laboratory Dr RTP, NC 27709, U.S.A	US0067	2180C	825374
<input checked="" type="checkbox"/>	Building: 2800 Perimeter Park Dr. Suite B Morrisville, NC 27560, U.S.A		27265	

4. DECISION RULES AND MEASUREMENT UNCERTAINTY (RF EXPOSURE)

4.1. METROLOGICAL TRACEABILITY

All test and measuring equipment utilized to perform the tests documented in this report are calibrated on a regular basis, with a maximum time between calibrations of one year or the manufacturers' recommendation, whichever is less, and where applicable is traceable to recognized national standards.

4.2. DECISION RULES

The Decision Rule is based on Simple Acceptance in accordance with ISO Guide 98-4:2012 Clause 8.2. (Measurement uncertainty is not taken into account when stating conformity with a specified requirement.)

4.3. MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus:

PARAMETER	U_{Lab}
Magnetic Field Reading (A/m)	+/-0.3 dB
Electric Field Reading (V/m)	+/-0.3 dB

Uncertainty figures are valid to a confidence level of 95.45%.

5. EQUIPMENT UNDER TEST

5.1. DESCRIPTION OF EUT

Signo Reader is a smartcard reader typically installed near doorway as part of physical access system, to control access to that door. A user will approach the door and present a BLE or RFID credentials to the reader with intention of entering the door. The reader will read the credential and send its data to a connected access control panel, which determine whether or not grant the user access to the door. Optionally, a personal identification number (PIN) may also be required, in which case the user will enter the PIN on the reader's keypad.

The EUT supports the following technologies:

Wireless technologies	Frequency Band(s)	Operating mode(s)
NFC	13.56MHz	Type A 106, 212, 424 & 848 Kbps
	125KHz	4 Kbps
Bluetooth	2.4 GHz	LE 1 & 2 Mbps
Notes: 1. The EUT operated in a 1x1 SISO mode. 2. The EUT only supports 1 type(s) of NFC tag.		

5.2. SOFTWARE AND FIRMWARE

The firmware version installed in the EUT during testing was:

The EUT firmware installed during testing was 10.1

The test utility software used during testing was Rev H

5.3. WORST-CASE CONFIGURATION AND MODE

The following configurations were tested as worst-case position:

Config	Descriptions	Frequency
1	Tag Off	13.56 MHz
2	Tag On (Centered)	
3	(Offset to WC Positioning)	

Additionally, testing in five orientations at each of the five configurations were performed. These include top, center, front, left, and right. Only the worst-case data per configuration is included in the report.

5.4. DESCRIPTION OF TEST SETUP

SUPPORT EQUIPMENT

Support Equipment List				
Description	Manufacturer	Model	Serial Number	FCC ID
Laptop	Lenovo	Yoga 7 16IAP7	PF49WDF9	-
Laptop	Lenovo	T14 Gen3	PF4FKW01	-
Laptop Charger	Lenovo	ADLX65YLC2D	8ssa10R16920L1CZ35T1VXJ	-
USB to Type C cable	ANKER	-	-	-
Data Module	HID	-	PCB-00476	-
Laptop	Lenovo	IdeaPad Flex 5 14IAU7	PW0DWR8R	TX2-RTL8852BE

I/O CABLES

I/O Cable List						
Cable No.	Port	# of Identical Ports	Connector Type	Cable Type	Cable Length (m)	Remarks
1	DC	1	10pin proprietary	Unshielded	<3m	Used to connect EUT to DC Power Supply.

5.5. MEASUREMENT SETUP

The measurements were taken using a probe placed 20 cm surrounding the device for all configurations.

20cm distance E-field and H-field are evaluated from the center of the Narda probe.

For measurement setup and all testing photos, refer to external photos exhibit R15701621-EP3e

6. TEST AND MEASUREMENT EQUIPMENT

The following test and measurement equipment was used for the tests documented in this report:

Test Equipment Used - Line-Conducted Emissions – Voltage (Morrisville – Conducted 1)

Equipment ID	Description	Manufacturer	Model Number	Last Cal.	Next Cal.
Electric and Magnetic Field Probe	Narda	EHP-200AC	FA0001	2024-08-19	2025-08-19

7. DUTY CYCLE

LIMITS

None; for reporting purposes only.

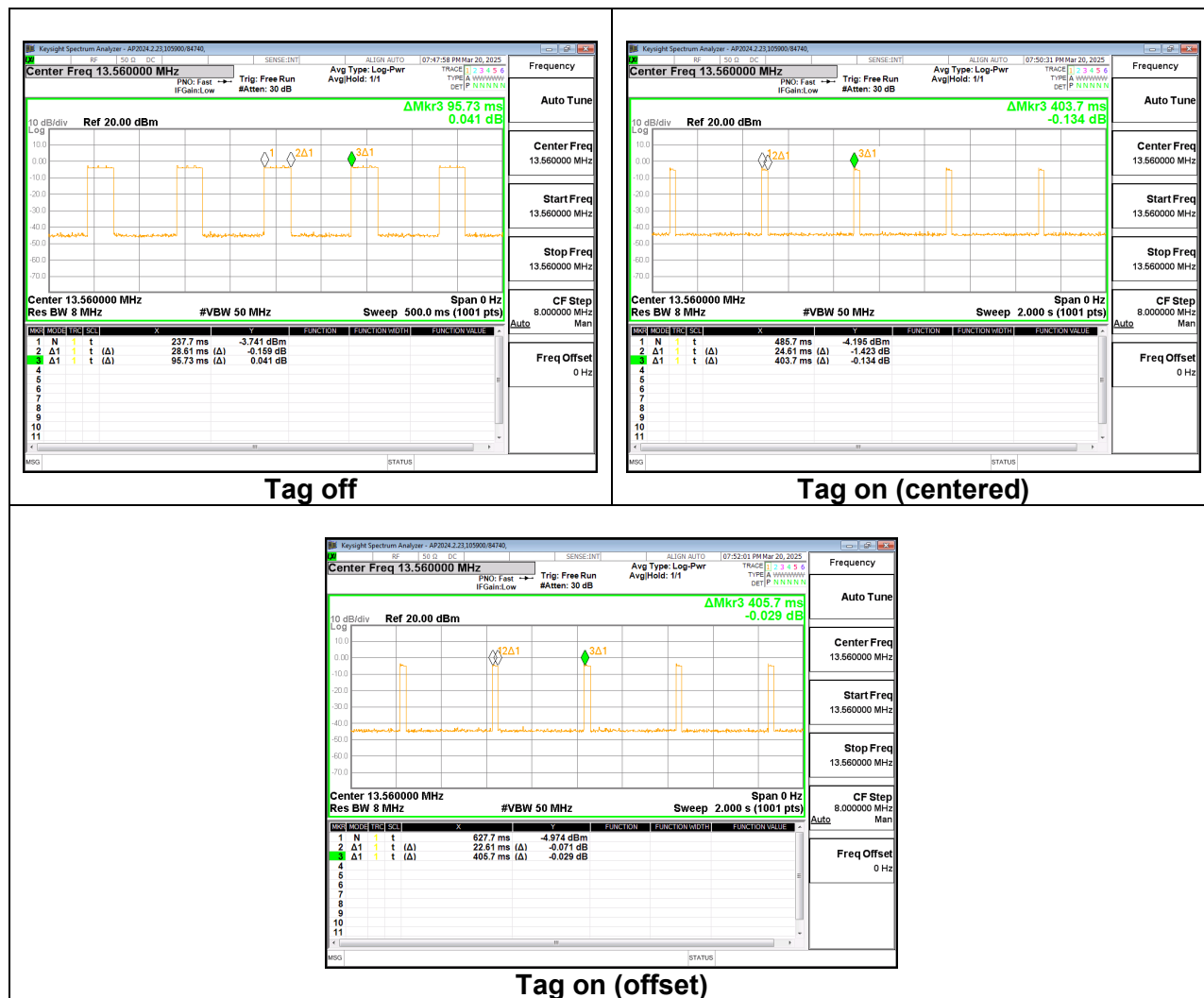
PROCEDURE

Zero-Span Spectrum Analyzer Method.

ON TIME AND DUTY CYCLE RESULTS

Test Engineer:	105900/84740
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Configuration	Frequency (MHz)	ON Time B (msec)	Period (msec)	Duty Cycle x (linear)	Duty Cycle (%)	Duty Cycle Correction Factor (dB)
Tag off	13.56	28.61	95.73	0.30	29.89	NA
Tag on (centered)	13.56	24.61	403.70	0.06	6.10	NA
Tag on (offset)	13.56	22.61	405.70	0.06	5.57	NA



8. MAXIMUM PERMISSIBLE RF EXPOSURE

8.1. FCC LIMITS AND SUMMARY

§1.1310 The criteria listed in Table 1 shall be used to evaluate the environmental impact of human exposure to radiofrequency (RF) radiation as specified in §1.1307(b), except in the case of portable devices which shall be evaluated according to the provisions of §2.1093 of this chapter.

Table 1 to § 1.1310(e)(1) - Limits for Maximum Permissible Exposure (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm ²)	Averaging time (minutes)
(i) Limits for Occupational/Controlled Exposure				
0.3-3.0	614	1.63	*(100)	≤6
3.0-30	1842/f	4.89/f	*(900/f ²)	<6
30-300	61.4	0.163	1.0	<6
300-1,500			f/300	<6
1,500-100,000			5	<6
(ii) Limits for General Population/Uncontrolled Exposure				
0.3-1.34	614	1.63	*(100)	<30
1.34-30	824/f	2.19/f	*(180/f ²)	<30
30-300	27.5	0.073	0.2	<30
300-1,500			f/1500	<30
1,500-100,000			1.0	<30

f = frequency in MHz. * = Plane-wave equivalent power density.

Using the table above, the limits for uncontrolled exposure to 13.56 MHz RFID radio is 60.77 V/m and 0.16 A/m.

RESULT:

Test Engineer:	105900/84740	Test Date:	2025-03-19 to 2025-04-22
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8.2. IC LIMITS

Radio Standards Specification 102, Issue 5 Radio Frequency (RF) Exposure Compliance of Radio communication Apparatus (All Frequency Bands), sets out the requirements and measurement techniques used to evaluate radio frequency (RF) exposure compliance of radio communication apparatus designed to be used within the vicinity of the human body

The electric and magnetic field strength reference levels, power density reference levels, and associated reference period for devices employed by the general public (uncontrolled environment) and controlled-use devices (controlled environment) are specified in table 7 and table 8. Note that the power density limits specified in these tables apply to whole body exposure conditions.

Table 7: RF field strength and power density limits for devices used by the general public (uncontrolled environment)

Frequency range (MHz)	Electric field (V _{RMS} /m)	Magnetic field (A _{RMS} /m)	Power density (W/m ²)	Reference period (minutes)
10-20	27.46	0.0728	2	6
20-48	58.07 / $f^{0.25}$	0.1540 / $f^{0.25}$	8.944 / $f^{0.5}$	6
48-300	22.06	0.05852	1.291	6
300-6000	3.142 $f^{0.3417}$	0.008335 $f^{0.3417}$	0.02619 $f^{0.6834}$	6
6000-15000	61.4	0.163	10	6
15000-150000	61.4	0.163	10	616000 / $f^{1.2}$
150000-300000	0.158 $f^{0.5}$	4.21×10 ⁻⁴ $f^{0.5}$	6.67×10 ⁻⁵ f	616000 / $f^{1.2}$

Note: f is frequency in MHz.

8.2.1. MAXIMUM RESULT SUMMARY RF EXPOSURE (FCC)

CONFIGURATION 1: TAG OFF

Electric Field Limit			Magnetic Field Limit		
FCC RF Exposure Limit (V/m)	Maximum Average (V/m)	Percentage (%)	FCC RF Exposure (A/m)	Maximum Average (A/m)	Percentage (%)
60.77	8.360	13.76%	0.16	0.040785	25.49%

CONFIGURATION 2: TAG ON (CENTERED)

Electric Field Limit			Magnetic Field Limit		
FCC RF Exposure Limit (V/m)	Maximum Average (V/m)	Percentage (%)	FCC RF Exposure (A/m)	Maximum Average (A/m)	Percentage (%)
60.77	3.636	5.983%	0.16	0.028	17.5%

CONFIGURATION 3: TAG ON (OFFSET)

Electric Field Limit			Magnetic Field Limit		
FCC RF Exposure Limit (V/m)	Maximum Average (V/m)	Percentage (%)	FCC RF Exposure (A/m)	Maximum Average (A/m)	Percentage (%)
60.77	3.348	5.51%	0.16	0.031	19.38%

8.2.2. MAXIMUM RESULT SUMMARY RF EXPOSURE (RSS 102)

CONFIGURATION 1: TAG OFF

Electric Field Limit			Magnetic Field Limit		
IC RF Exposure Limit (V/m)	Maximum Average (V/m)	Percentage (%)	IC RF Exposure Limit (A/m)	Maximum Average (A/m)	Percentage (%)
27.46	8.360	30.44%	0.0728	0.040785	56.02%

CONFIGURATION 2: TAG ON (CENTERED)

Electric Field Limit			Magnetic Field Limit		
IC RF Exposure Limit (V/m)	Maximum Average (V/m)	Percentage (%)	IC RF Exposure Limit (A/m)	Maximum Average (A/m)	Percentage (%)
27.46	3.636	13.2%	0.0728	0.028	38.5%

CONFIGURATION 3: TAG ON (OFFSET)

Electric Field Limit			Magnetic Field Limit		
IC RF Exposure Limit (V/m)	Maximum Average (V/m)	Percentage (%)	IC RF Exposure Limit (A/m)	Maximum Average (A/m)	Percentage (%)
27.46	3.348	12.2%	0.0728	0.031	42.6%

8.2.3. E- FIELD AND H- FIELD MEASUREMENTS (FCC)

Note: Peak measurements were performed. RMS values were calculated from the peak measurement. Please refer to the formula for calculating the RMS values: [Field Strength x $\sqrt{\text{Duty Cycle}}$].

CONFIGURATION 1: TAG OFF

Configuration	Test Mode	Measuring Distance (cm)	Electric Field Limit (V/m)	Electric Field Reading (V/m)				Magnetic Field Limit (A/m)	Magnetic Field Reading (A/m)			
			FCC	Location	Peak	Duty Cycle %	FCC Average	FCC	Location	Peak	Duty Cycle %	FCC Average
1	NA	20	60.77	Bottom	10.800	29.89	5.905	0.16	Bottom	0.0296	29.86	0.016
				Center	4.5890		2.50889		Center	0.0746		0.040785
				Left	15.291		8.360		Left	0.0284		0.016
				Right	13.652		7.464		Right	0.0317		0.017
				Top	11.536		3.069		Top	0.0300		0.016
				Max	15.291		8.360		Max	0.0746		0.040785

CONFIGURATION 2: TAG ON (CENTERED)

Configuration	Test Mode	Measuring Distance (cm)	Electric Field Limit (V/m)	Electric Field Reading (V/m)				Magnetic Field Limit (A/m)	Magnetic Field Reading (A/m)			
			FCC	Location	Peak	Duty Cycle %	FCC Average	FCC	Location	Peak	Duty Cycle %	FCC Average
2	NA	20	60.77	Bottom	9.0218	6.10	2.228	0.16	Bottom	0.0283	6.10	0.007
				Center	14.720		3.636		Center	0.1118		0.028
				Left	12.261		3.028		Left	0.0305		0.008
				Right	14.256		3.521		Right	0.0302		0.007
				Top	12.121		2.994		Top	0.0287		0.007
				Max	14.720		3.636		Max	0.1118		0.028

CONFIGURATION 3: TAG ON (OFFSET)

Configuration	Test Mode	Measuring Distance (cm)	Electric Field Limit (V/m)	Electric Field Reading (V/m)				Magnetic Field Limit (A/m)	Magnetic Field Reading (A/m)			
			FCC	Location	Peak	Duty Cycle %	FCC Average	FCC	Location	Peak	Duty Cycle %	FCC Average
3	NA	20	60.77	Bottom	7.5894	5.57	1.791	0.16	Bottom	0.0273	5.57	0.006
				Center	14.695		3.468		Center	0.1332		0.031
				Left	10.262		2.422		Left	0.0292		0.007
				Right	12.133		2.863		Right	0.0294		0.007
				Top	11.461		2.705		Top	0.0278		0.007
				Max	14.695		3.468		Max	0.1332		0.031

8.2.4. E- FIELD AND H- FIELD MEASUREMENTS (IC)

Note: Peak measurements were performed. RMS values were calculated from the peak measurement. Please refer to the formula for calculating the RMS values: $[\text{Field Strength} \times \sqrt{\text{Duty Cycle}}]$.

CONFIGURATION 1: TAG OFF

Configuration	Test Mode	Measuring Distance (cm)	Electric Field Limit (V/m)	Electric Field Reading (V/m)				Magnetic Field Limit (A/m)	Magnetic Field Reading (A/m)			
			FCC	Location	Peak	Duty Cycle %	FCC Average	FCC	Location	Peak	Duty Cycle %	FCC Average
1	NA	20	27.46	Bottom	10.800	29.89	5.905	0.0728	Bottom	0.0296	29.86	0.016
				Center	4.5890		2.50889		Center	0.0746		0.040785
				Left	15.291		8.360		Left	0.0284		0.016
				Right	13.652		7.464		Right	0.0317		0.017
				Top	11.536		3.069		Top	0.0300		0.016
				Max	15.291		8.360		Max	0.0746		0.040785

CONFIGURATION 2: TAG ON (CENTERED)

Configuration	Test Mode	Measuring Distance (cm)	Electric Field Limit (V/m)	Electric Field Reading (V/m)				Magnetic Field Limit (A/m)	Magnetic Field Reading (A/m)			
			FCC	Location	Peak	Duty Cycle %	FCC Average	FCC	Location	Peak	Duty Cycle %	FCC Average
2	NA	20	27.46	Bottom	9.0218	6.10	2.228	0.16	Bottom	0.0283	6.10	0.007
				Center	14.720		3.636		Center	0.1118		0.028
				Left	12.261		3.028		Left	0.0305		0.008
				Right	14.256		3.521		Right	0.0302		0.007
				Top	12.121		2.994		Top	0.0287		0.007
				Max	14.720		3.636		Max	0.1118		0.028

CONFIGURATION 3: TAG ON (OFFSET)

Configuration	Test Mode	Measuring Distance (cm)	Electric Field Limit (V/m)	Electric Field Reading (V/m)				Magnetic Field Limit (A/m)	Magnetic Field Reading (A/m)			
			FCC	Location	Peak	Duty Cycle %	FCC Average	FCC	Location	Peak	Duty Cycle %	FCC Average
3	NA	20	27.46	Bottom	7.5894	5.57	1.791	0.0728	Bottom	0.0273	5.57	0.006
				Center	14.695		3.468		Center	0.1332		0.031
				Left	10.262		2.422		Left	0.0292		0.007
				Right	12.133		2.863		Right	0.0294		0.007
				Top	11.461		2.705		Top	0.0278		0.007
				Max	14.695		3.468		Max	0.1332		0.031

9. RF EXPOSURE TEST SETUP AND SETUP PHOTO

For measurement setup and all testing photos, refer to external photos exhibit R15613923-EP3e

END OF REPORT